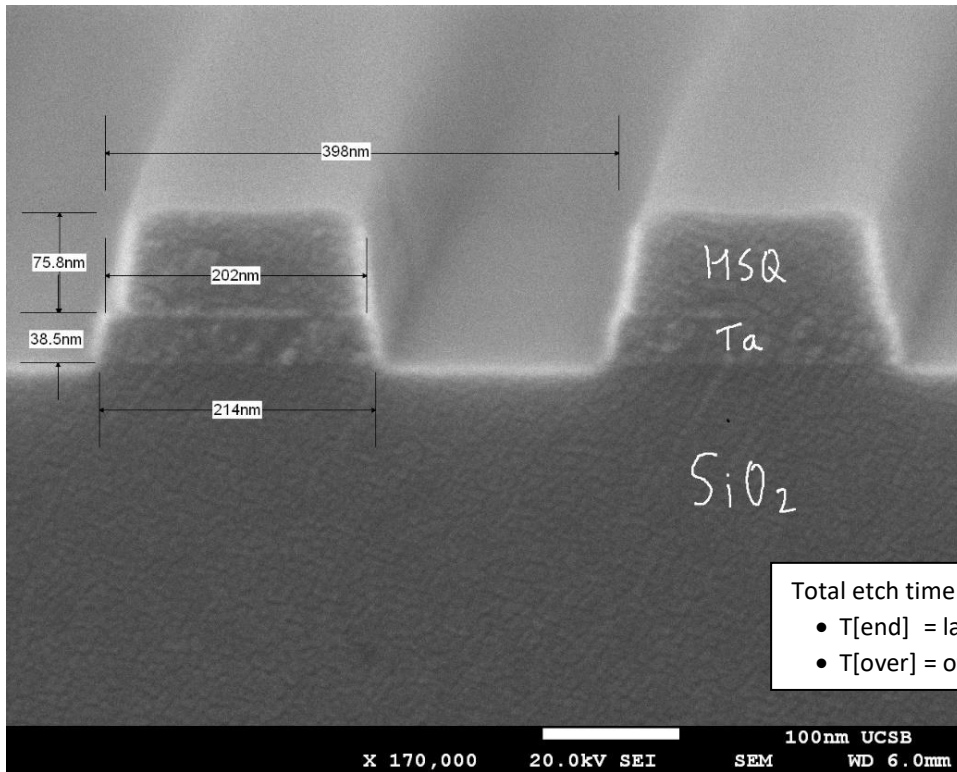


# ICP1: recipe = #104 Ta Etch

(developed by Bill Mitchell, Nanofab process group)

<b><u>Substrate structure</u></b>	<i>Ta(35nm)/SiO2(300nm)/Si</i>	
<b><u>Masking resist</u></b>	<i>HSQ(~120nm)</i>	
<b><u>Plasma Powers</u></b>	<b>ICP</b>	<i>500W</i>
	<b>CCP[bias]</b>	<i>50W</i>
<b><u>Gas Flows</u></b>	<b>Cl2</b>	<i>30sccm</i>
	<b>BCl3</b>	<i>10sccm</i>
	<b>Ar</b>	<i>0sccm</i>
<b><u>Gas Pressures</u></b>	<b>Etch step</b>	<i>1Pa</i>
	<b>Ignition step</b>	<i>1Pa (no Cl2 in initial step to avoid thermal etch component!)</i>
<b><u>Etch Data</u></b>		
<b>Etch Rate</b> (via laser monitor)	<i>Ta ~ 70nm/min, HSQ ~ 65nm/min</i>	
<b>Etch angle</b>	<i>~81 degrees (&lt;90° =&gt; tapered)</i>	



Total etch time = T[end] + T[over] = 40s

- T[end] = laser monitor endpoint = 30s
- T[over] = over etch = 10s